

Search Notes**Application/Control No.**

10/614,350

Examiner

Due N. Tran

Applicant(s)/Patent under Reexamination

GOTO ET AL.

Art Unit

2841

SEARCHED

Class	Subclass	Date	Examiner
361	816	7/5/2005	DUE
361	818	7/5/2005	DUE
361	51	7/5/2005	DUE
361	760	7/5/2005	DUE
361	767	7/5/2005	DUE
174	35R	7/5/2005	DUE
174	35GC	7/5/2005	DUE
174	51	7/5/2005	DUE
174	52.1	7/5/2005	DUE
174	52.2	7/5/2005	DUE
361	800	7/5/2005	DUE
361	803	7/5/2005	DUE
174	52.4	7/5/2005	DUE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted Hung Ngo on finding the lip dimension and 174 search	6/15/2005	DUE
Consulted Phuong Vu on the search field	6/13/2005	DUE
Consulted Hung Bui on the search field for solder layer	6/13/2005	DUE
East search strategy attached		